

LONGCHEER TECHNOLOGY (SHANGHAI) CO., LTD.

RECIPIENT

SPECIFICATIONS

Product No. : X1G003591002400

MODEL : TG-5025CG-27G

SPEC. No. : A16-025-0B

DATE : Apr. 8. 2016

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SPECIFICATIONS

1. Application

This document is applicable to the temperature compensated crystal oscillator (TCXO) that is delivered to **LONGCHEER TECHNOLOGY (SHANGHAI) CO., LTD.** from SEIKO EPSON Corp.

This product is compliant with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by SEIKO EPSON Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes.

Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use.

We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

2. Product No. / Model

The product No. of this crystal oscillator unit is **X1G003591002400**.

The model is **TG-5025CG-27G**

3. Packing

It is subject to the packing standard of SEIKO EPSON Corp.

4. Amendment and abolishment

Amendment and/or abolishment of this specification are subject to the agreement of both parties.

5. Contents

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[1] Characteristics

- Lead Free Reflowable and ultra small SMD($2.5 \times 2.0 \times 0.9$ mm).
- Using the heat-resisting type AT cut quartz crystal allows almost the same temperature soldering as universal SMD IC.
- Operating supply voltage : 2.65 V.

[2] Absolute maximum ratings

Parameter	Symbol	Value	Unit	Note
Supply voltage	V _{CC} -GND	-0.3 to 4.5	V	
Storage temperature range	T _{stg}	-40 to +85	°C	
Frequency control voltage	V _c -GND	V _c -GND	V	

[3] Operating range

Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Supply voltage	V _{CC}	2.55	2.65	2.80	V	
	GND	0.0		0.0	V	
Operating temperature range	T _{use}	-25		+85	°C	
Frequency control voltage	V _c	0.4	1.1	2.0	V	
Output load	Load_R	9	10	11	kΩ	
	Load_C	9	10	11	pF	
DC-cut capacitor	C _c	0.01			μF	

DC-cut capacitor is not included in this TCXO.

Please attach an external DC-cut capacitor (0.01 μF Min.) to the out pin.

[4] Frequency characteristics

1) Output frequency 38.400000 MHz

2) Frequency characteristics

(Condition : $V_{CC}=2.65\text{ V}$, $V_C=1.1\text{ V}$, $GND=0.0\text{ V}$, Load $10\text{ k}\cdot //10\text{ pF}$ (DC cut), $T_a=+25^\circ\text{C}$)

Parameter	Symbol	Value			Unit	Note
		Min.		Max.		
Frequency tolerance	$f_{\text{tol(osc)}}$	-1.5	-	+1.5	$\times 10^{-6}$	$T_{\text{use}} = +25^\circ\text{C} \pm 2^\circ\text{C}$ Reflow cycles : 2 times *2
Frequency / Temperature characteristics	$f_o\text{-}T_c$	-0.5	-	+0.5	$\times 10^{-6}$	$T_{\text{use}} = -25^\circ\text{C}$ to $+85^\circ\text{C}$ Based on frequency at $+25^\circ\text{C}$
Frequency / Load coefficient	$f_o\text{-}Load$	-0.2	-	+0.2	$\times 10^{-6}$	Load : $10\text{ k}\Omega // 10\text{ pF} \pm 10\%$ each
Frequency / Voltage coefficient	$f_o\text{-}V_{CC}$	-0.2	-	+0.2	$\times 10^{-6}$	$V_{CC} = 2.65\text{ V} \pm 0.1\text{ V}$
Frequency aging	f_{age}	-1.0	-	+1.0	$\times 10^{-6}$	First year $T_{\text{use}} = +25^\circ\text{C}$

*1 Include initial frequency tolerance and frequency deviation after reflow cycles.

*2 Measurement of frequency deviation is made 24h after reflow soldering.

3) Frequency adjustment characteristics

(Condition : $V_{CC}=2.65\text{ V}$, $V_C=1.1\text{ V}$, $GND=0.0\text{ V}$, Load $10\text{ k}\cdot //10\text{ pF}$ (DC cut), $T_a=+25^\circ\text{C}$)

Parameter	Sym	Value			Unit	Note
		Min.	Typ.	Max.		
Frequency control range	f_{cont}	+6	-	+10	$\times 10^{-6}$	$V_C = 0.4\text{ V}$ to 2.0 V
Input impedance (V_C terminal)	R_{IN}	500	-	-	$\text{k}\Omega$	$V_C\text{-}GND$ (DC level)
Transfer function	-	Positive polarity			-	

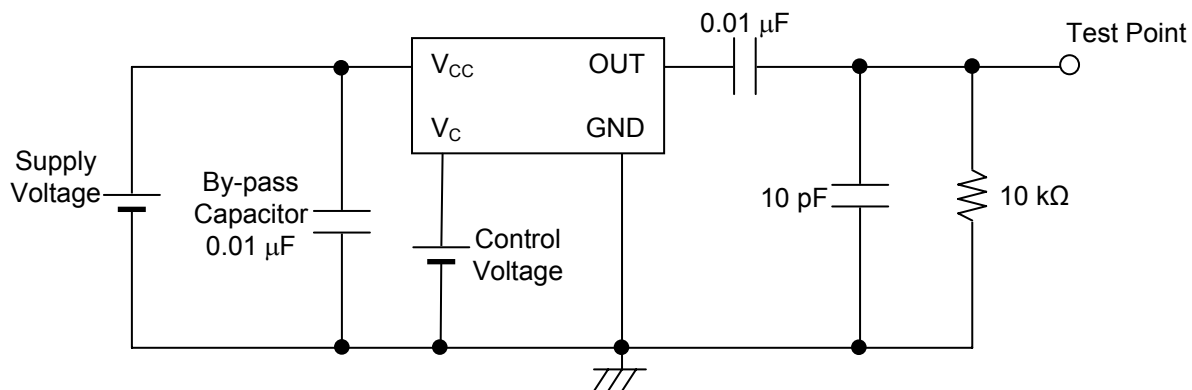
[5] Electrical characteristics

(Condition : $V_{CC}=2.65\text{ V}$, $V_C=1.1\text{ V}$, $GND=0.0\text{ V}$, Load $10\text{ k}\cdot //10\text{ pF}$ (DC cut), $T_a=+25^\circ\text{C}$)

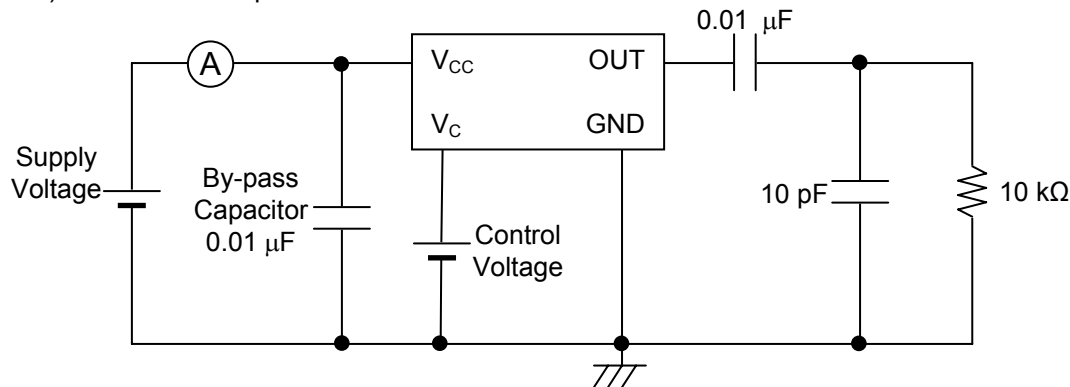
Parameter	Symbol	Value			Unit	Note
		Min.	Typ.	Max.		
Start up time	t_{str}			2.0	msec	$dF = \pm 1.0 \times 10^{-6}$ 90 % V_{p-p}
Current consumption	I_{CC}	-	1.5	2.0	mA	Load $10\text{ k}\Omega // 10\text{ pF}$
Output level	V_{PP}	0.8	-	-	V	Peak to peak voltage
Symmetry	SYM	40	-	60	%	GND Level
Harmonics	-	-	-	-5	dBc	
SSB Phase noise	$L(f)$	-	-134	-130	dBc /Hz	Offset : 1 Hz

[6] Test circuit

1) Output Load : 10 k Ω //10 pF



2) Current consumption



3) Conditions

- | | | |
|------------------|-------------------|-------------------|
| 1. Oscilloscope: | Impedance | Min. 1 M Ω |
| | Input capacitance | Max. 10 pF |
| | Band width | Min. 300 MHz |

Impossible to measure both frequency and wave form at the same time.(In case of using oscilloscope's amplifier output, possible to measure both at the same time.)

2. Load_C includes probe capacitance.
3. A capacitor (By-pass:0.01 μ F) is placed between V_{CC} and GND,and closely to TCXO.
4. Use the current meter whose internal impedance value is small.
5. Power Supply
Impedance of power supply should be as low as possible.
6. GND pin should be connected to low impedance GND.

[7] Environmental and mechanical characteristics

(The company evaluation condition. we evaluate it by the following examination item and examination condition.)

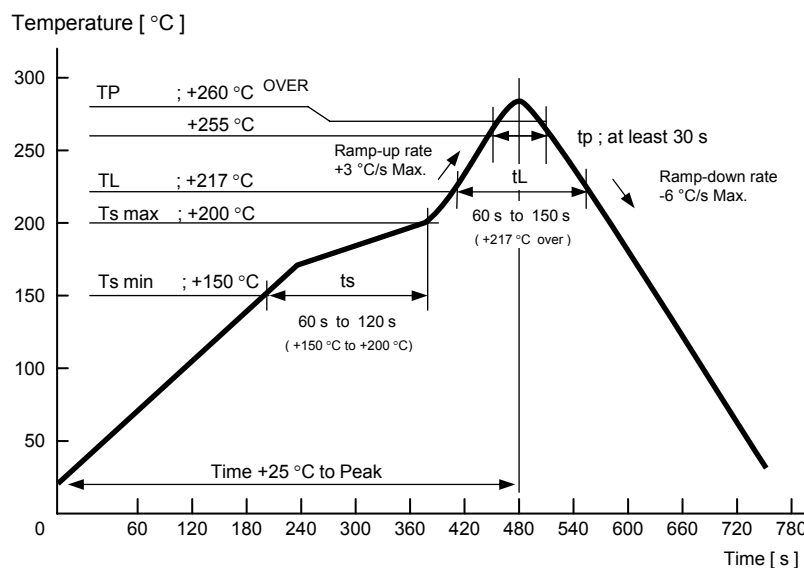
No.	Item	Value *1	Test method
		Freq. Tolerance [1×10^{-6}] *2 Electrical characteristics	
1	High temp. storage *3	± 2.0	+85 °C × 1000 h
2	Low temp. storage *3	± 2.0	-40 °C × 1000 h
3	High temp. with humidity	± 2.0	+85 °C × 85%RH × 1000 h
4	Temp. cycle *3	± 2.0	-40 °C to +85 °C (30 min × 100 cycle/each)
5	Resistance to Soldering heat (Reflow characteristics)	± 1.0	Reflow furnace with the condition 3 times
6	Drop	± 2.0	150g dummy jig (SEIKO EPSON Standard) drop from 1500 mm height on the concrete 6 directions 3 times.
7	Vibration	± 2.0	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s^2 10 Hz → 500 Hz → 10 Hz 15 min / cycle 6 h (2 h × 3 directions)
8	Solderability	Terminals must be 95 % covered with fresh solder	Dip termination into solder bath at +235 °C for 5 s (Using Rosin Flux)

Notes

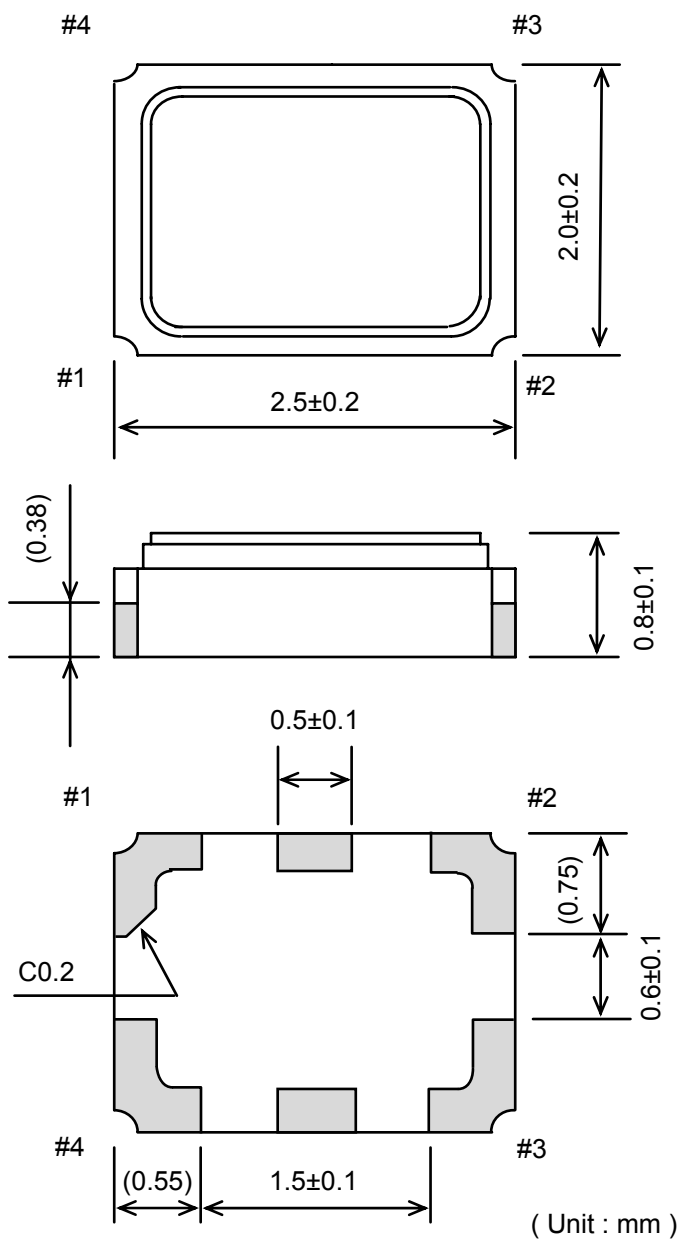
- *1 each test is independent.
- *2 measuring 2 h to 24 h later leaving in room temperature after each test.
- *3 Initial value shall be measured after 24 h storage at room temperature Pre-treatment

Pre-treatment : Bake (+125°C x 24 h) → Moisture soak (+85°C x 85 % x 168 h) → reflow (3 times)

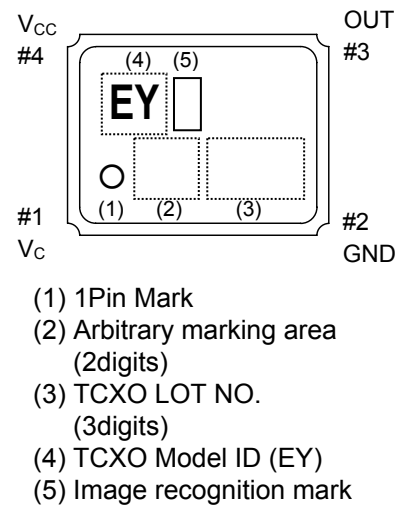
Reflow condition (follow to IPC / JEDEC J-STD-020D.1)



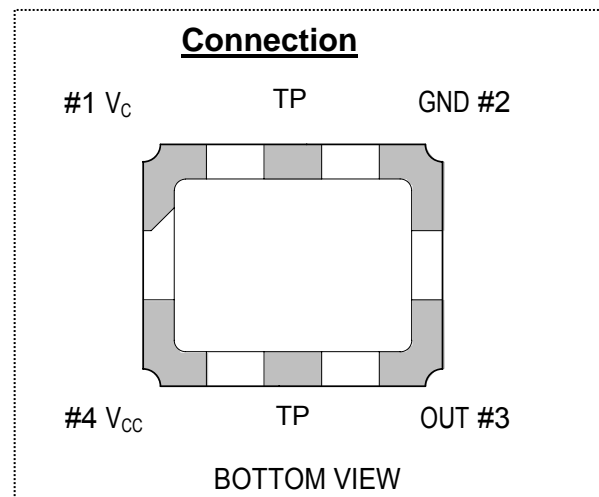
[8] Dimensions and marking layout



Marking



Connection



Material

Base : Ceramics
Terminal : Au plated nickel

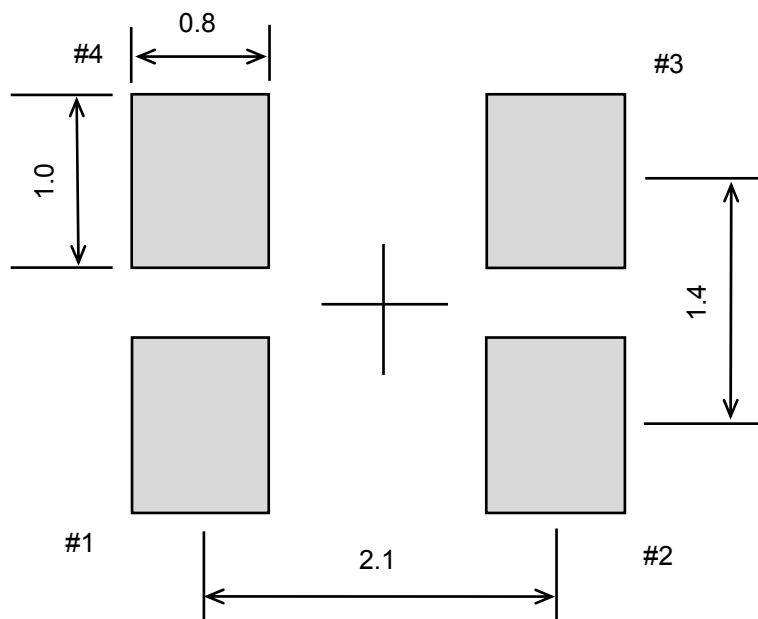
[9] Recommendable patterning

For actual design work, please consider optimum condition together with mounting density, reliability of soldering and mount ability etc.

To maintain stable operation, provide a 0.01uF to 0.1uF by-pass capacitor at a location as near as possible to the power source terminal of the crystal product (between Vcc - GND).

Soldering position

(Unit : mm)



[10] Handling precautions

Prior to using this product, please carefully read the section entitled “Precautions” on our Web site (<http://www5.epsondevice.com/en/quartz/tech/precaution/>) for instructions on how to handle and use the product properly to ensure optimal performance of the product in your equipment. Before using the product under any conditions other than those specified therein, please consult with us to verify and confirm that the performance of the product will not be negatively affected by use under such conditions.

In addition to the foregoing precautions, in order to avoid the deteriorating performance of the product, we strongly recommend that you DO NOT use the product under ANY of the following conditions:

- (1) Mounting the product on a board using water-soluble solder flux and using the product without removing the residue of the flux completely from the board. The residue of such flux that is soluble in water or water-soluble cleaning agent, especially the residues which contains active halogens, will negatively affect the performance and reliability of the product.
- (2) Using the product in any manner that will result in any shock or impact to the product.
- (3) Using the product in places where the product is exposed to water, chemicals, organic solvent, sunlight, dust, corrosive gasses, or other materials.
- (4) Using the product in places where the product is exposed to static electricity or electromagnetic waves.
- (5) Applying ultrasonic cleaning without advance verification and confirmation that the product will not be affected by such a cleaning process, because it may damage the crystal, IC and/or metal line of the product.
- (6) Touching the IC surface with tweezers or other hard materials directly.
- (7) Using the product under any other conditions that may negatively affect the performance and/or reliability of the product.
- (8) Using the product with power line ripple exceeding 50 mV(p-p) level.

Should any customer use the product in any manner contrary to the precautions and/or advice herein, such use shall be done at the customer’s own risk.

TAPING SPECIFICATION

テープ梱包基準書

1. APPLICATION 適用範囲

This document is applicable to 2.5 x 2.0 SMD package.

本基準書は、2.5 x 2.0 セラミックパッケージのテーピング梱包について規定する。

2. CONTENTS 目次

Item No.	Item	Page
[1]	Taping specification テーピング仕様	1 to 2
[2]	Inner Sleeve スリーブへの収納	3
[3]	Shipping carton 外装箱への収納	
[4]	Marking 表示	4
[5]	Quantity 収納数量	
[6]	Storage environment 保管環境	
[7]	Handling リール取扱い	

[1] Taping specification テーピング仕様

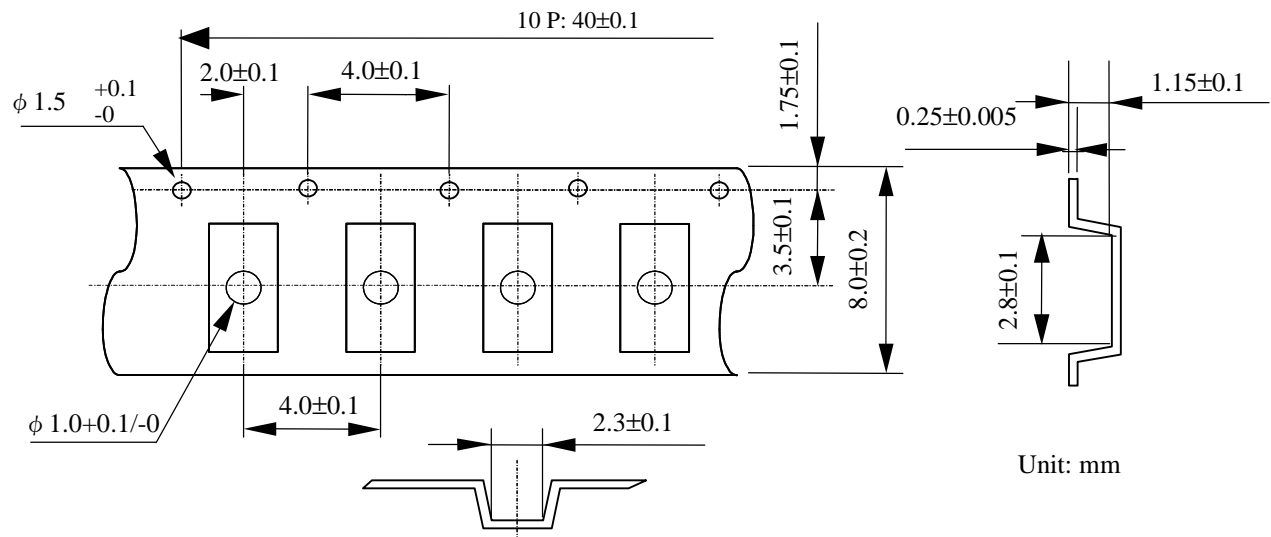
Subject to EIA-481 , IEC 60286.

「EIA-481」「IEC 60286」に準拠する。

(1) Tape dimensions TE0804L

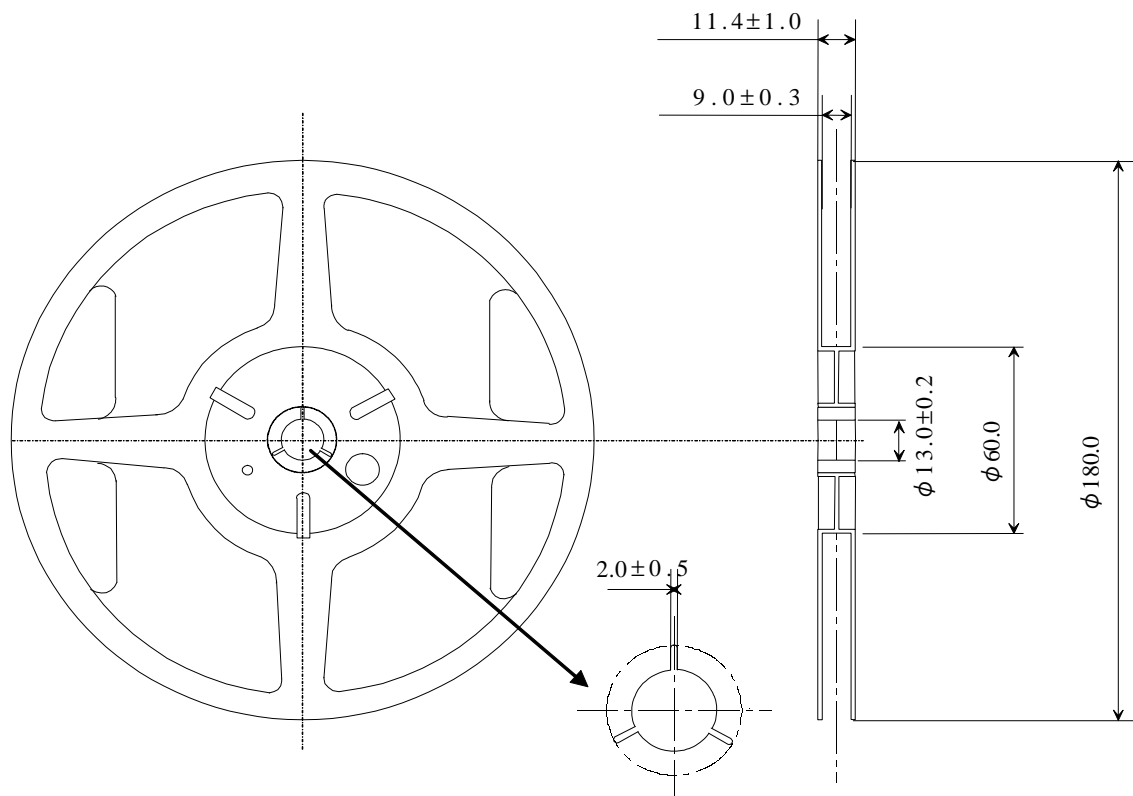
Material of the Carrier Tape キャリアテープ材質: PS (Black / Conductive 黒/導電性)

Material of the Top Tape トップテープ材質 : PET+PE



(2) Reel dimensions

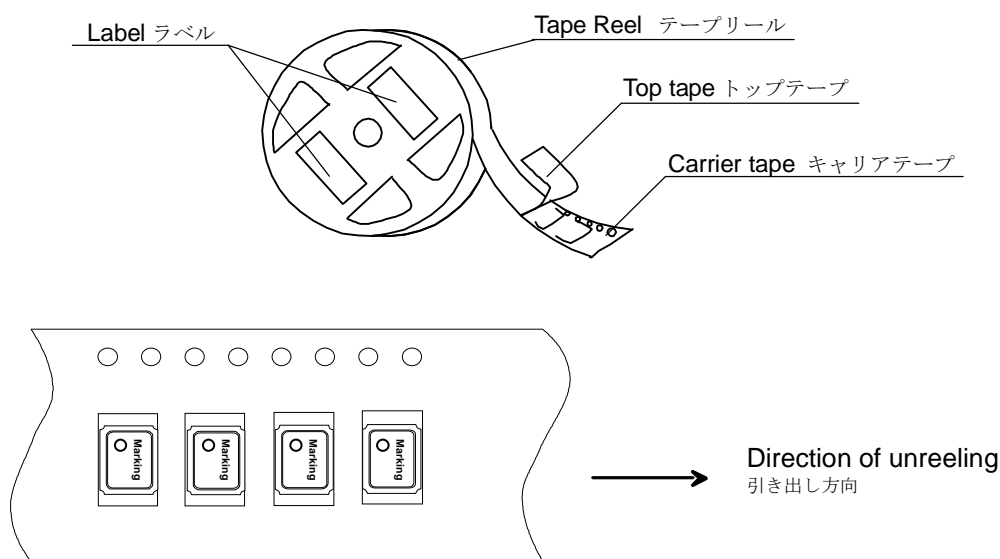
Material of the Reel リール材質: PS (Black / Conductive 黒/導電性)



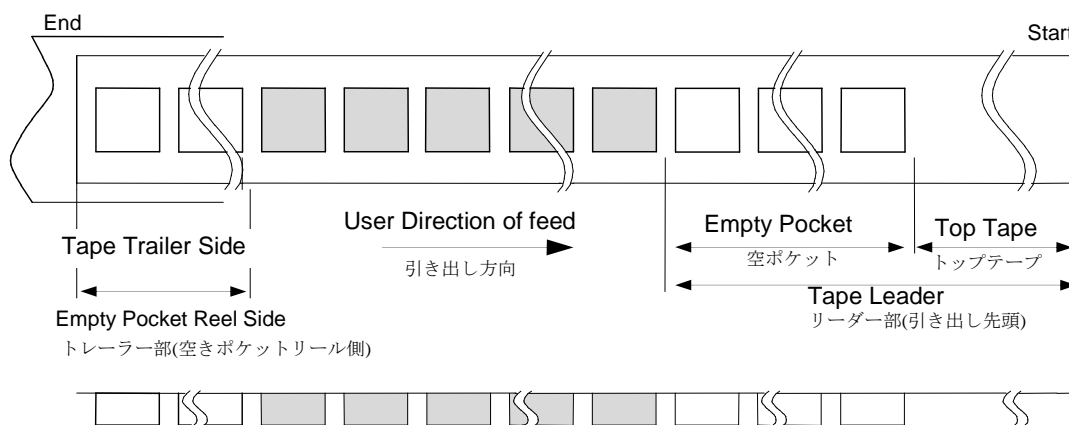
Form and Size of reel window shows are one of the example

リールの窓の形状は代表例を掲載。

(3) Packing 収納形態
(a) Tape & Reel デバイス収納方法



(b) Start & End Point 引き出し先頭側及びリール側の処理



Item 項目		Empty Space 空きスペース	Note 備考
Tape Leader (引き出し先頭側)	Top Tape	Min. 200 mm	Feeding in the Top tape, the tip is fixed with tape. トップテープ単独で繰り出し、先端はテープにより固定。
	Carrier Tape	Min. 150 mm	Winding method is a diagram of the above リールへの巻き取り方法は、上図の通り。
Tape Trailer (リール側)	Top Tape	Min. 0 mm	Tip is fixed to the reel. 先端はリールに固定。
	Carrier Tape	Min. 150 mm	

(4) Peel force of the cover tape トップテープの剥離強度

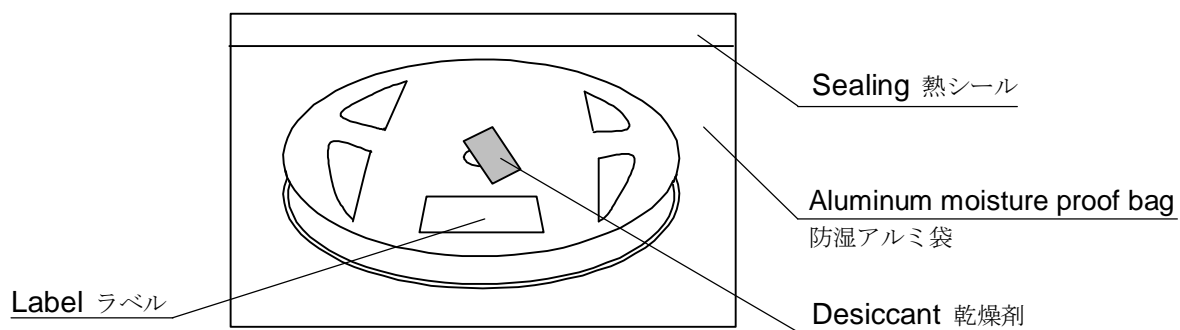
(a) Angle: cover tape during peel off and the direction of unreeling shall be 165° to 180°.
剥離角度: テープの接着面に対し 165~180 度とする。

(b) Peel speed: 300 mm/min.
剥離速度: 300 mm/min とする。

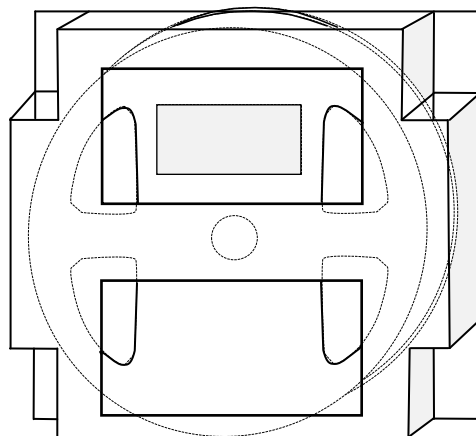
(c) Peel strength: 0.1 ~ 1.0 N.
剥離強度: 0.1~1.0 N

[2] Inner sleeve

a) Packing to antistatic bag 袋への収納



b) Packing to inner sleeve スリーブへの収納

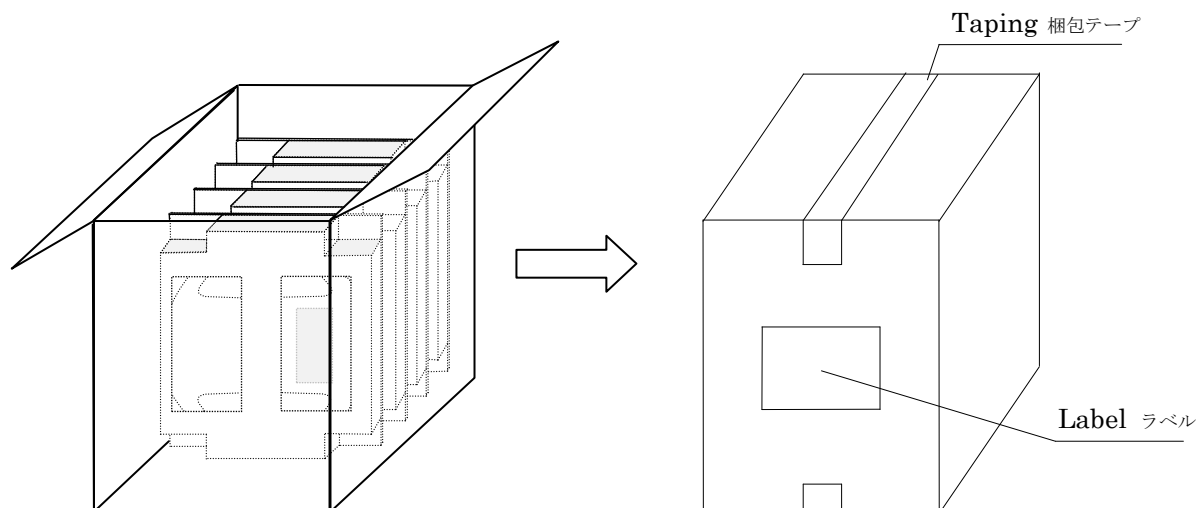


*There is also a case to put the two reel.

* 2 リール収納される場合もあります。

[3] Shipping Carton 外装箱への収納

- Put inner sleeve into an outer box.
外装箱の中へ、スリーブを収納する。
- If there is space in the outer box, material is put in a shock absorbing together.
空間ができた時は、クッション材を入れる。



[4] Marking 表示

(1) Reel marking リールへの表示

- Reel marking shall consist of

下記内容をリール表面に表示できるラベルを貼る。:

- 1) Parts name 製品名称
- 2) Quantity 製品数量
- 3) Manufacturing Date or symbol 製品の製造年月又はこれを示す記号
- 4) Manufacturer's Date or symbol 製品の製造業者又はその略号
- 5) Others (if necessary) その他必要事項

(2) Shipping carton marking 外装箱への表示

- Shipping carton marking shall consist of :

下記内容を外装箱表面に表示できるラベルを貼る。:

- 1) Parts name 製品名称
- 2) Quantity 製品数量

[5] Quantity 収納数量

- Maximum 2 000 pcs./reel 最大 2,000 個/リール
- Minimum 500 pcs./reel 最小 500 個/リール

[6] Storage environment 保管環境

(1) Before open the packing, we recommend to keep less than +30 °C and 60 %RH of Humidity, and to use it less than 6 months after delivery.

開梱前の製品は、温度 +30 °C、湿度 60 %RH 以下での保管をして下さい。

貴社納入後、袋未開封で 6 ヶ月以内の実装を推奨します。

(2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 4 weeks. No need dry air before soldering work if it is less than temperature +30 °C, 60 humidity %RH. When keeping 4 weeks are exceeded after the opening, it is recommended to be used after soldering is confirmed.

使用直前まで開梱せず、袋開封後は 4 週間以内の実装を推奨します。

温度 +30 °C、湿度 60 %RH 以下では、はんだ付け作業前に乾燥不要です。

開封後保管 4 週間を超えた場合は半田付け性を確認の上使用されることを推奨します。

(3) Not to storage with some erosive chemicals.

化学薬品類との同居を避ける。

(4) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

内・外装箱がゆがまないようまた、外圧がかからないように保管して下さい。

[7] Handling リール取扱い

To handle with care to prevent the damage of tape, reel and products.

リールの取扱いについては、中のテープ・製品を変形させないようにして下さい。

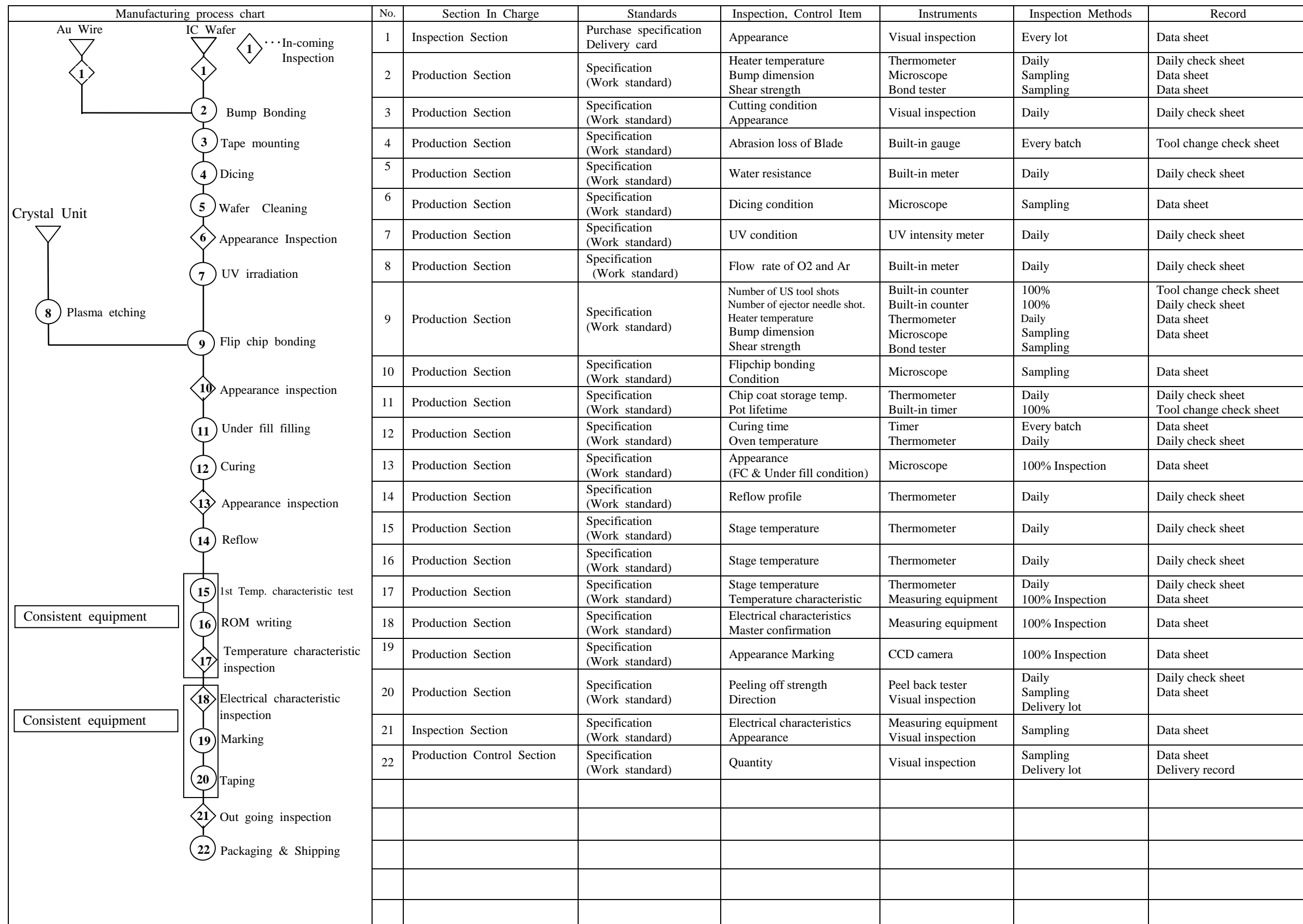
- PROCESS QUALITY CONTROL -

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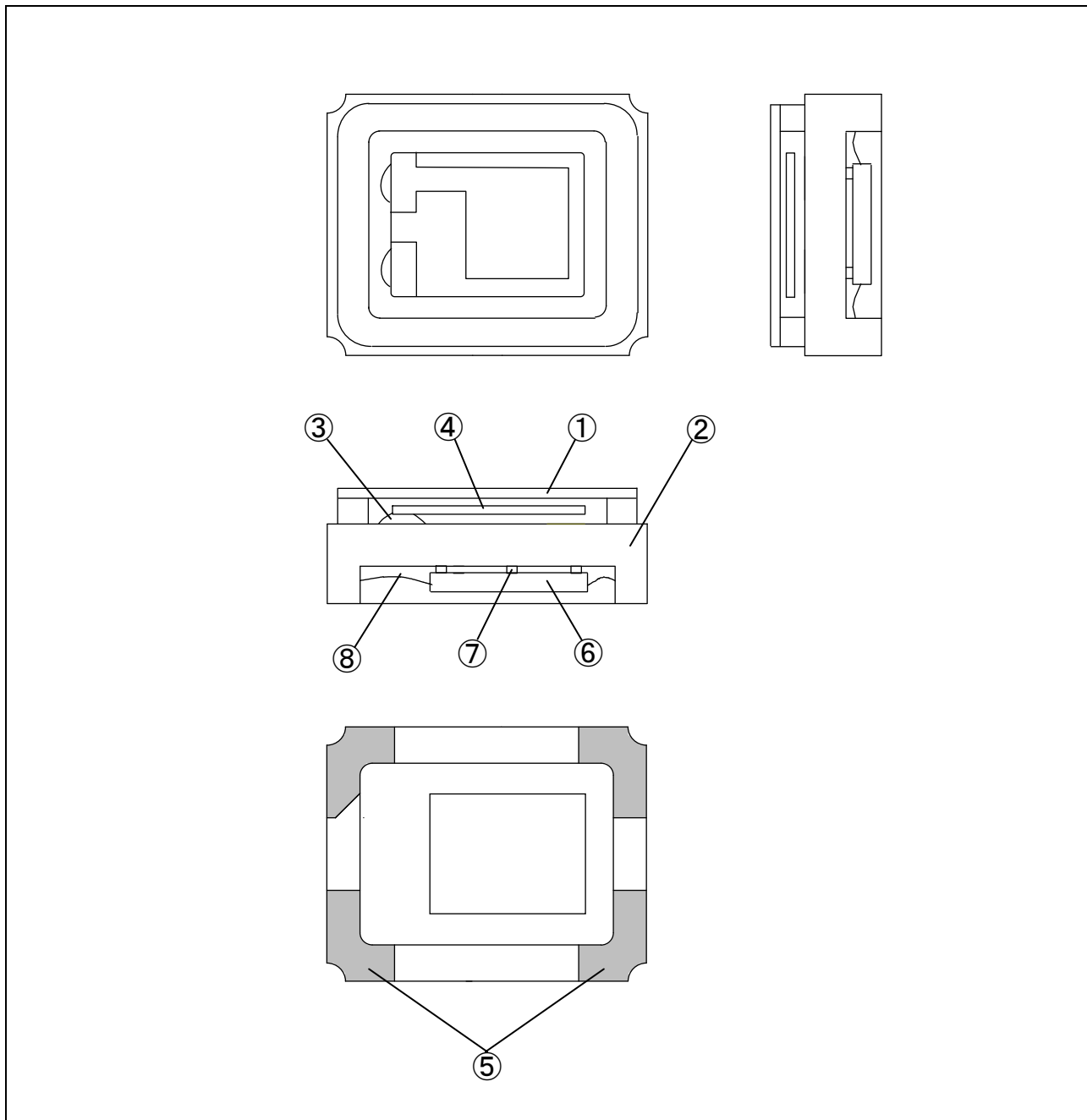
SEIKO EPSON CORP.

TG-50xxCx_Q_0001

CRYSTAL OSCILLATOR : TG-50xxCx series



Structure Diagram 構造図		Rev.02
Model 型式	TG-50xxCE / TG-50xxCG / TG-50xxCJ	
Document No. 管理No.	TG-50xxCx_D_0001	



No.	Name of Part 部品名	No.	Name of Part 部品名
①	Lid リッド	⑤	Terminal 端子
②	Package パッケージ	⑥	IC IC
③	Crystal adhesive 接着材	⑦	FC bump FC バンプ
④	Crystal chip 水晶片	⑧	Underfill アンダーフィル

RELIABILITY TEST DATA

Product Name : TG-50xxCG series

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition .

DTA-1510_E

No.	ITEM	TEST CONDITIONS	VALUE *1		TEST	FAIL
			$\Delta f / f$ *2 [1×10^{-6}]	Electrical characteristics	Qty [n]	Qty [n]
1	High temperature storage	+85 °C × 1 000 h	*3 ± 2.0	Satisfy output level after test	22	0
2	Low temperature storage	-40 °C × 1 000 h	*3 ± 2.0		22	0
3	High Temperature with Humidity	+85 ± 2 °C × 85 ± 5 %RH × 1 000 h	*3 ± 2.0		22	0
4	Temperature cycle	-40 °C ⇔ +85 °C 30 min at each temp. 1000 cycles	*3 ± 2.0		22	0
5	Resistance to soldering heat	Convection reflow soldering furnace (3 times)	± 1.0		22	0
6	Drop	150g dummy jig (SEIKO EPSON Standard) drop from 1500 mm height on the concrete 6 directions 3 times.	± 2.0		22	0
7	Vibration	10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz → 500 Hz → 10 Hz 15 min / cycle 6 h (2 h × 3 directions)	± 2.0		22	0
8	Solderability	Dip termination into solder bath at +235 °C ± 5 °C for 5 s (Using Rosin Flux)	Termination must be covered with fresh solder more than 95 % of dip area.		11	0

Notes

- *1 Each test done independently.
- *2 Measuring 2 h to 24 h later leaving in room temperature after each test.
- *3 Initial value shall be measured after 24 h storage at room temperature Pre-treatment
Pre-treatment : Bake (+125 °C × 24 h) →Moisture soak (+85 °C × 60 % × 168 h) →reflow (3 times)

Product Name : TG-50xxCG series

df / f

